## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10591876	MIYASHITA, TAKASHIGE
Examiner	Art Unit
Hai Phan	2614

SEARCHED			
Class	Subclass	Date	Examiner
381	94.1, 94.2, 94.3, 98, 99, 100	06/14/10	HP
327	554, 561	06/14/10	HP
455	307	06/14/10	HP

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search	06/14/10	HP
Inventor Search	06/14/10	HP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/Hai Phan/ Examiner.Art Unit 2614	

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